

MRI Gradient Subsystem Accelerated Reliability Test Using Nominal Day Usages

[1]Pradeep Kumar Anand- [1, 4] Electrical and Computer Engineering, Sungkyunkwan University, Suwon 16419, South Korea

[2]Dong Ryeol Shin - [2] College of Software, Sungkyunkwan University, Suwon 16419, South Korea

[3]Mudasar Latif Memon - [3] IBA Community College Naushahro Feroze, Sukkur IBA University, Sindh 65200, Pakistan

[4]Ranjita Kumari- [1, 4] Electrical and Computer Engineering, Sungkyunkwan University, Suwon 16419, South Korea

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Abstract:

This paper present a state of art to resolve MRI gradient subsystem unreliability by discovering its many failures and predicting its life before product launch by performing system reliability test as per nominal usage scenario, generating data during the test and computational of generated data using Big Data methodology. Using time of flight 3 dimensional (TOF3D) pulse sequence, a method has presented to stress the gradient subsystem to prove its long life (usually 10 years or more) within few months of accelerated reliability test based on hospital usage condition called as “Nominal Usage”. A computational algorithm has developed to calculate the gradient coil vibration energy stress over the 10 years of product life based on “nominal hospital usage condition” and scientifically matched with few months of reliability test by stressing the system using stringent TOF3D pulse sequence technique. We accelerated the test and perform 60 days of the test to prove the gradient coil reliability of 10 years of service life.

Keywords: Gradient subsystem life, Gradient coil, Life prediction using big data, Gradient coil reliability, MRI gradient coil.

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INTRODUCTION

From the last few decades, Magnetic Resonance Imaging (MRI) is one of the most popular medical imaging due to its advantage as non-ionization radiation compared to X-Ray or PET, etc systems. As the MRI system is complex and expensive, hence its unreliability over the long product life (usually >10 years) at customer place is the biggest issue for all Medical Device Manufacturer. All Medical Device manufacturer covers their system unreliability by providing frequent serviceability (almost every month), which increase the customer cost of ownership. This paper presents a state of art to resolve the MRI gradient subsystem unreliability before product launch by doing an accelerated reliability test [1]. Section II has a brief overview of

the MRI system and especially about the gradient subsystem. Section III of this paper explained the method to develop a nominal usage scenario based on hospital data. A nominal day workflow has also developed for a typical MRI system. The next section of this paper evaluated different kinds of stress conditions and identified the most stringent pulse sequence-based data analysis, which can stress the system most and accelerate the test [2-3]. Section IV describes the test cycle using time of flight 3 dimension (TOF3D) pulse sequences and break time. Test time has calculated based on test cycle stress conditions and overall gradient subsystem life. Section V has described the gradient coil accelerated reliability test result [2-3]. During the reliability test, enormous data was generated, which was

analyzed using big data and predicted the system life based on the test result. Last section VI described the conclusion and future scope related to gradient subsystem life prediction.

MRI GRADIENT SUBSYSTEM OVERVIEW

A MRI system mainly consists of magnet, gradient, RF subsystems. The magnet subsystem will produce the main directions (X, Y, Z). A magnetic gradient is applied in each axis using the gradient coil. Thus magnetic field varies linearly along each axis. The magnetic field will be added or subtracted from the main magnetic field B_0 based on the gradient field applied. Due to varying magnetic field, the resonance frequency will be different for the protons at a different place in the anatomy (human body) planned for imaging. A radio-frequency (RF) coil excites these protons by applying to transmit power and once the proton relaxes it produces reflected power, which is detected by the same RF coil. Reflected RF power forms the image dataset in the k space. Fourier transforms of k space produce the anatomical image. There are different ways, gradient and RF power can be applied based on pulse sequence techniques. During the usage in hospitals, the MRI gradient subsystem experiences many different failure modes and system breakdowns. Some of the predominant failures are gradient coil broken, overheating of gradient coil, shim coil failure, failure in gradient amplifier, gradient coil and shim coil temperature sensor failures. The main reason for failure is due to excessive gradient coil vibration & heat exerted due to varying magnetic fields inside gradient and shim coils. In section IV, data analyzed and produced to show that different pulse sequences with different gradient techniques exert different vibration to the gradient coil and other parts of gradient subsystem, which relates to gradient subsystem life. One of the big disadvantages of the MRI system is longer scanning time, which makes gradient subsystem reliability or life test more challenging to perform at the lab before product launch as it takes several years to complete the life test if planned to prove the reliability.

Hence, advanced scientific methods such as big data analysis and data mining techniques are needed to perform the accelerated life test in shorter test duration to prove the gradient subsystem life.

NOMINAL USAGE SCENARIO

To predict the life of the gradient subsystem and reliability, it is very important to analyze the actual hospital usage scenario of the MRI system. After analyzing several data sets from different hospitals and the web, the following data sets were collected to define the nominal usage scenario.

- Hospital 1: one-year exam data on 8 MRI systems
- Hospital 2: one-year exam data on 8 MRI systems
- Other web sources [4-7]

Once data sets were identified, we developed the nominal day usage profile as shown in Figure 1.

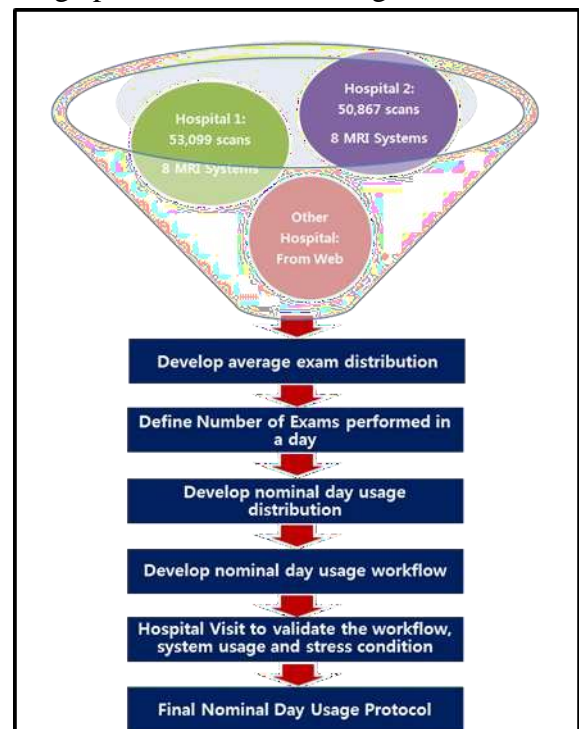


Figure 1. Strategy to develop “Nominal Day

Usage” of MRISystem

A. Data mining to Determine Exam Distribution

We collected the yearly MRI scan done on 2 hospitals and develop exam distribution based on the actual usage environment. In hospital 1 approximately 50867 exams and hospital 2 approximately 53099 exams were performed on the various anatomical region “Brain, Neck, Cervical Spine, Lumbar Spine, Liver, Abdomen, lower extremities (hand, wrist, knee, ankle), upper extremities (shoulder, thigh)” in a year. After data mining, exam distribution was developed for hospital 1 and 2 and then averaged it to make the data more nominal. Later, these exam distributions further averaged with other exam distribution data from the National Health Service (NHS) to make it more realistic as shown in Figure 2. The National Health Service is a very reliable source of healthcare information and data from the United Kingdom.

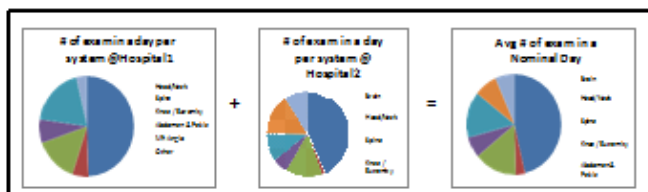


Figure 2. MRI Exam Distribution

Based on these analyses, the following exam distribution was developed:

Brain: 31%
Head & Neck: 6%
Spine: 21%
Extremities: 15%
MR angiography: 8%
Abdomen & Pelvis: 11%
Other: 8%

B. Average Number of Exams in a Day

The next step is to find out the average number of MRI exams performed in a day. Typically, 6 days in a week and 50 weeks in a year hospitals across the globe use the MRI system to get a

faster return on investment (ROI).

of scans/day in Hospital 1 = $(50867/50 \times 6 \times 8) = 21.2$
of scans/day in Hospital 2 = $(53099/50 \times 6 \times 8) = 22.1$
of scans/day as per NHS = $(1980000/50 \times 6 \times 304) = 21.7$
Average number of exams in a day = $(21.2 + 22.1 + 21.7)/3 = 21.7$

C. Nominal Day Usage Distribution

Using exam distribution and the number of exams performed in a day, we develop nominal day usage distribution. A typical target diagnosis is also applied with each exam to correctly estimate the pulse sequence used to perform the MRI scan.

D. Nominal Day Usage Workflow

Based on hospital workflow to perform the MRI system scans throughout the day and nominal day exam distribution developed in the previous section, we develop the MRI workflow as per steps shown in Figure 1.

E. Validate the Usage Workflow by Hospital Visit

We visited one of the most prestigious multispecialty hospital in South Korea and study the MRI system used throughout the day to validate our nominal day usage workflow. Our study was focused to study about stress on gradient subsystem based on the pulse sequence applied, time gaps between each pulse sequence, and break between two exams.

F. Final Nominal Day Usage Protocol

Based on all previous steps, we finalized the nominal day usage protocol. We determine the time to perform the nominal day protocol in our lab as approximately 5.8 hours.

GRADIENT SUBSYSTEM STRESS CONDITIONS

As described in Section I of this paper, the MRI system undergoes through different stress throughout the day. One of these stresses is excessive vibration due to the gradient coil due to the varying magnetic field. Each exam identified in section III of this paper needs to have a different pulse sequence, which exerts different vibration to gradient coil and magnet system based on kind of varying magnetic field.

A. Pulse Sequences & Vibration Energy

A model has developed to calculate vibration energy applied based on different pulse sequence parameters. Figure 5 shows vibration energy applied by different pulse sequences, which reveals that the TOF3D pulse sequence exerts maximum vibration ~58J to gradient coil and hence the MRI system, which way higher than all other pulse sequence techniques.

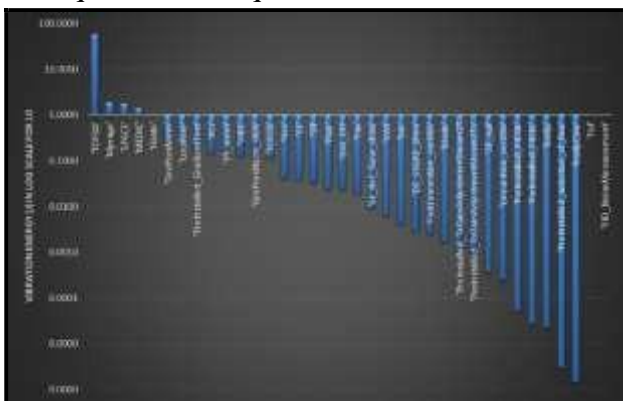


Figure 3. Vibration Energy (log scale with base 10) Vs MRI Pulse Sequence

B. Life Time Analysis using Vibration Energy

Based on the nominal day usage profile consist of 21 exams, which has predefined pulse sequences based on target diagnosis of anatomy as described in section III, gradient coil vibration energy is calculated. In one day,

gradient coil undergoes through 193.3J.

ACCELERATED RELIABILITY TEST RESULT

Usually accelerated reliability test is performed on a system with many unknown failure modes, which is difficult to identify by analysis (FMEA) or normal verification or reliability test. We perform the accelerated reliability test using a nominal day usage scenario representing its actual life in the hospital. During the test, we found several failures, which was fixed and the test is continued till the gradient subsystem achieve a predetermined target annual service life.

A. Defining Test Cycle

In section IV of this paper, vibration energy applied to the MRI system is maximum (58J) during the TOF3D pulse sequence. Based on many permutation and combination test cycle was developed consisting of 10 TOF3D pulse sequences test with 1-hour break to accelerate the system reliability test. Vibration Energy applied in one test cycle is

Joule.

Vibration energy applied in a nominal day
= 193.3 Joule Number of clinical day/week
= 6

Number of clinical weeks/year =
50 Product Life = 10

Lifetime vibration energy = 193.3 Joule

Vibration energy applied in a test cycle
= 580.3 Joule Acceleration factor =
 $(580.3 / 193.3)^{1.5} = 5.2$

Time to complete one test cycle =
2.29 hours Test hours per day = 24
hours

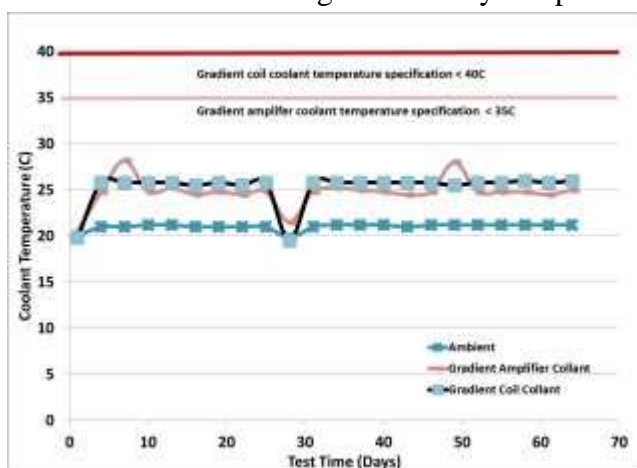
Acceleration factor due to time = 24 /
2.29 = 10.5 Total acceleration factor
= 5.2 x 10.5 = 54.5

Time to complete the test = $(10 \times 50 \times 6) / 54.5$

= 55 days

B. Performing Test

We perform the test for 60 days on a 3T MRI system to prove the gradient subsystem 10 years of life. During the test, the gradient subsystem has broken down several times due to fire in gradient subsystem terminal block, gradient coil sensors failure, overheating of gradient coil, and some software failures. These failures have fixed and the test is continued till it achieved a gradient subsystem predetermined



mined life. We monitored the following parameters:

- Gradient subsystem terminal block
- Gradient coil temperature
- Gradient coil coolant temperature
- Gradient amplifier temperature
- And several other parameters for software & system

C. Analyzing the Test Results and Failures

We analyzed test results and identified all the issues, fixed

it and continued the test until it achieved its equivalent 10 years of target life.

Figure 4 shows the gradient and shim coil thermal performance. We took an average of different sensors reading and maximum temperature of a day to plot the graph. It shows both gradient and shim coil has stable

performance as the maximum temperature limit is 80°C.

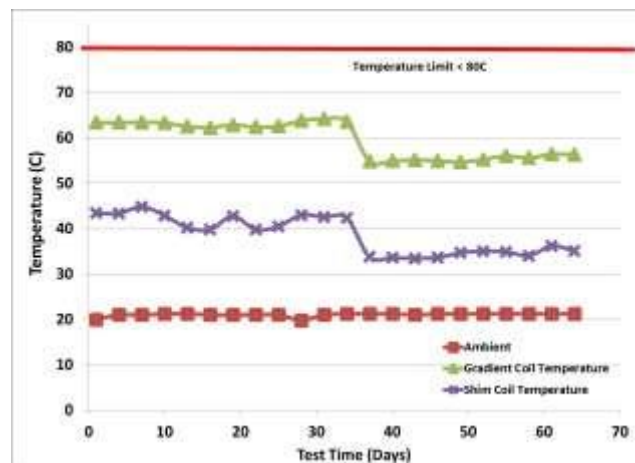


Figure 4. Gradient subsystem performance

Figure 5. Gradient subsystem coolant temperature performance

Figure 5 plot the thermal performance of the gradient coil and amplifier coolant temperature. There is no abnormality observed except for some fluctuation in a few days. Gradient coil and amplifier temperature limits are 40°C and 35°C, respectively.

During the test, several other issues found related to software, which was fixed and the test was continued to meet 10 years of target life.

CONCLUSION

Using the nominal day usage scenario, it is possible to perform an accelerated reliability test of MRI gradient coil representing its 10 years life. We performed 60 days of accelerated reliability test for a gradient subsystem of a 3T MRI system to prove 10 years of service life before the product launch. This concept can be further applied in other complex medical devices or other complex non-medical device subsystems and systems.

References

1. Dimitri B. Kececioglu, Reliability & Life Testing Handbook Department of Aerospace & Mechanical Engineering, By The University of

Arizona(2002).

2. Nelson, W. Accelerated life testing - step-stress models and data analyses. *IEEE transactions on reliability*, June 1980, 29(2), 103-108.
3. Ecker, M.; Gerschler, J.B.; Vogel, J.; Käbitz, S.; Hust, F.; Dechent, P.; Sauer, D.U. Development of a lifetime prediction model for lithium-ion batteries based on extended accelerated aging test data. *Journal of Power Sources*, October 2012, 215, 248-257.
4. MRI Exam Distribution, By European Magnetic Resonance Forum (EMRF), 2017, 11th edition.
5. Diagnostic Imaging Dataset (DID) Report, By Health and Social Care Information Centre, UK, 2015.
6. MRI Organ Distribution, European Magnetic Resonance Forum (EMRF) data from OECD (Organization of Economic Cooperation and Development) and WHO, 2015.
7. Anand, P.K., Shin, D.R., Saxena, N. and Memon, M.L. Accelerated Reliability Growth Test for Magnetic Resonance Imaging System Using Time-of-Flight Three-Dimensional Pulse Sequence. *Diagnostics*, 9(4), p.164, 2019.